

Application/Control	No. Applicant(s)/Patent und Reexamination	der
10/646,810	IMACHI ET AL.	
Examiner	Art Unit	
Helen O. Chu	1745	

SEARCHED					
Class	Subclass	Date	Examiner		
429	121	4/18/2006	нс		
429	122	4/18/2006	нс		
429	199	4/18/2006	нс		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Palm and Edan (Inventor Search)	4/18/2006	нс
East Search (East Notes Attached)	4/18/2006	НС
Plus Search	4/18/2006	нс